A 12 V, 18 mΩ, 6 A Load Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output

General Description

The SLG59H1126V is a high-performance, self-powered 18 mΩ NMOS load switch designed for all 4.5 V to 12 V power rails up to 6 A. Using a proprietary MOSFET design, the SLG59H1126V achieves a stable 18 mΩ RDS_{ON} across a wide input voltage range. In combining novel FET design and copper pillar interconnects, the SLG59H1126V package also exhibits a low thermal resistance for high-current operation.

Designed to operate over a -40 °C to 85 °C range, the SLG59H1126V is available in a low thermal resistance, RoHS-compliant, 1.6 x 3.0 mm STQFN package.

Features

- Wide Operating Input Voltage: 4.5 V to 13.2 V
- Maximum Continuous Current: 6 A
- Automatic nFET SOA Protection
  - 5 W SOA Protection Threshold
- High-performance MOSFET Switch
  Low RDS_{ON}: 18 mΩ at V_{IN} = 12 V
  Low $\Delta RDS_{ON}/\Delta V_{IN}$: < 0.05 mΩ/V
  Low $\Delta RDS_{ON}/\Delta T$: < 0.06 mΩ/°C
- 2-Level, Pin-selectable V_{IN} Overvoltage Lockout
- Capacitor-adjustable Inrush Current Control
- Two stage Current Limit Protection:
  Resistor-adjustable Active Current Limit
  Internal Short-circuit Current limit
- Open Drain $\overline{FAULT}$ Signaling
- MOSFET Current Analog Output Monitor: 10 µA/A
- Fast 4 kΩ Output Discharge
 - Pb-Free / Halogen-Free / RoHS Compliant Packaging

Pin Configuration

18-pin STQFN
1.6 x 3.0 mm, 0.40mm pitch
(Top View)
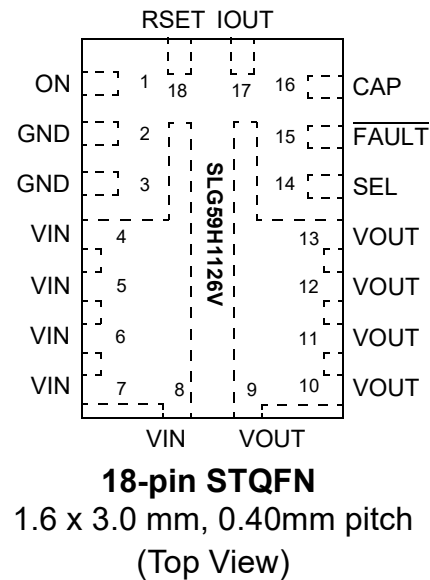
Applications

- Enterprise Computing & Telecom Equipment
  5 V and 12 V Point-of-Load Power Distribution
- PCI/PCIe Adapter Cards
- General-purpose High-voltage, Power-Rail Switching
- Multifunction Printers
- Fan Motor Control

Block Diagram and a 12 V / 3 A Typical Application Circuit
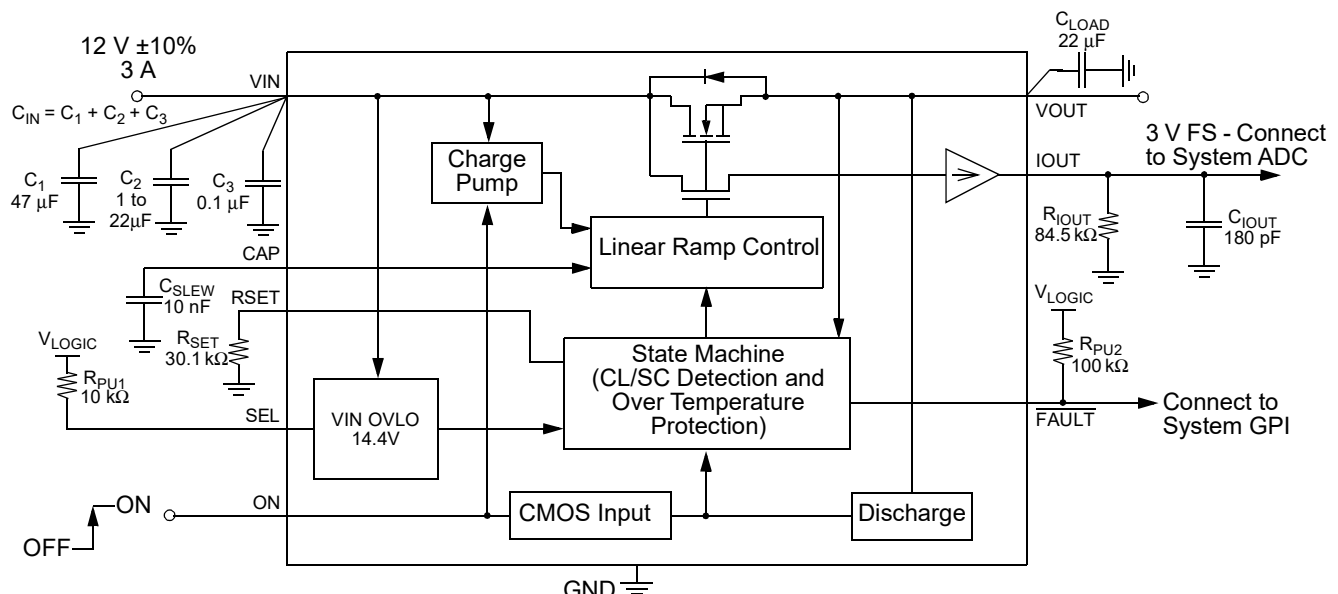
A 12 V, 18 mΩ, 6 A Load Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output

Pin Description

Pin #	Pin Name	Type	Pin Description
1	ON	Input	A low-to-high transition on this pin initiates the operation of the SLG59H1126V's state machine. ON is an asserted HIGH, level-sensitive CMOS input with ON_V_{IL} < 0.3 V and ON_V_{IH} > 0.9 V. As the ON pin input circuit does not have an internal pull-down resistor, connect this pin to a general-purpose output (GPO) of a microcontroller, an application processor, or a system controller – do not allow this pin to be open-circuited.
2	GND	GND	Low-current ground terminal. Connect this pin directly to Pin 3
3	GND	GND	Pin 3 is the main ground connection for the SLG59H1126V's internal charge pump, its gate driver and current-limit circuits as well as its internal state machine. Therefore, use a short, stout connection from Pin 3 to the system's analog or power plane.
4-8	VIN	MOSFET	VIN supplies the power for the operation of the SLG59H1126V, its internal control circuitry, and the drain terminal of the nFET load switch. With 5 pins fused together at VIN, connect a 47 µF (or larger) low-ESR capacitor from this pin to ground. Capacitors used at VIN should be rated at 50 V or higher.
9-13	VOUT	MOSFET	Source terminal of n-channel MOSFET (5 pins fused for VOUT). Connect a 22 µF (or larger) low-ESR capacitor from this pin to ground. Capacitors used at VOUT should be rated at 50 V or higher.
14	SEL	Input	As level-sensitive, CMOS inputs with SEL_V_{IL} < 0.3 V and SEL_V_{IH} > 1.65 V, the SEL pin selects one of two V_{IN} overvoltage lockout thresholds. Please see the Applications Section for additional information and the Electrical Characteristics table for the V_{IN} overvoltage thresholds. A logic LOW is achieved by connecting the pin to GND; a logic HIGH achieved by connecting a 10 kΩ external resistor from the pin to the system's local logic supply.
15	$\overline{FAULT}$	Output	An open drain output, $\overline{FAULT}$ is asserted within $T\overline{FAULT}_{LOW}$ when a V_{IN} overvoltage, a current-limit, or an over-temperature condition is detected. $\overline{FAULT}$ is deasserted within $T\overline{FAULT}_{HIGH}$ when the fault condition is removed. Connect an 100 kΩ external resistor from the $\overline{FAULT}$ pin to local system logic supply.
16	CAP	Output	A low-ESR, stable dielectric, ceramic surface-mount capacitor connected from CAP pin to GND sets the V_{OUT} slew rate and overall turn-on time of the SLG59H1126V. For best performance, the range for C_{SLEW} values are 10 nF ≤ C_{SLEW} ≤ 20 nF – please see typical characteristics for additional information. Capacitors used at the CAP pin should be rated at 10 V or higher. Please consult Applications Section on how to select C_{SLEW} based on V_{OUT} slew rate and loading conditions.
17	IOUT	Output	IOUT is the SLG59H1126V's power MOSFET load current monitor output. As an analog current output, this signal when applied to a ground-reference resistor generates a voltage proportional to the current through the n-channel MOSFET. The I_{OUT} transfer characteristic is typically 10 µA/A with a voltage compliance range of 0.5 V ≤ V_{IOUT} ≤ 4 V. Optimal I_{OUT} linearity is exhibited for 0.5 A ≤ I_{DS} ≤ 6 A. In addition, it is recommended to bypass the IOUT pin to GND with a 0.18 nF capacitor.
18	RSET	Input	A 1%-tolerance, metal-film resistor between 13.3 kΩ and 91 kΩ sets the SLG59H1126V's active current limit. A 91 kΩ resistor sets the SLG59H1126V's active current limit to 1 A and a 13.3 kΩ resistor sets the active current limit to 7 A.

Ordering Information Absolute Maximum Ratings

Part Number	Type	Production Flow
SLG59H1126V	STQFN 18L FC	Industrial, -40 °C to 85 °C
SLG59H1126VTR	STQFN 18L FC (Tape and Reel)	Industrial, -40 °C to 85 °C

A 12 V, 18 mΩ, 6 A Load Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output

Parameter	Description	Conditions	Min.	Typ.	Max.	Unit
V_{IN} to GND	Load Switch Input Voltage to GND	Continuous	-0.3	--	16	V
		Maximum pulsed V_{IN}, pulse width < 0.1 s	--	--	18	V
V_{OUT} to GND	Load Switch Output Voltage to GND		-0.3	--	V_{IN}	V
ON, SEL, CAP, RSET, IOUT, and FAULT to GND	ON, SEL, CAP, RSET, IOUT, and FAULT Pin Voltages to GND		-0.3	--	7	V
T_S	Storage Temperature		-65	--	150	°C
ESD_{HBM}	ESD Protection	Human Body Model	2000	--	--	V
ESD_{CDM}	ESD Protection	Charged Device Model	500	--	--	V
MSL	Moisture Sensitivity Level			1		
θ_{JA}	Thermal Resistance	1.6 x 3.0 mm 18L STQFN; Determined with the device mounted onto a 1 in^2, 1 oz. copper pad of FR-4 material	--	40	--	°C/W
MOSFET IDS_{CONT}	Continuous Current from VIN to VOUT	T_J < 150 °C	--	--	6	A
MOSFET IDS_{PEAK}	Peak Current from VIN to VOUT	Maximum pulsed switch current, pulse width < 1 ms	--	--	7	A

Note: Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

Electrical Characteristics

4.5 V ≤ V_{IN} ≤ 13.2 V; C_{IN} = 47 µF, T_A = -40 °C to 85 °C, unless otherwise noted. Typical values are at T_A = 25 °C

Parameter	Description	Conditions	Min.	Typ.	Max.	Unit
V_{IN}	Operating Input Voltage		4.5	--	13.2	V
$V_{IN(OVLO)}$	V_{IN} Overvoltage Lockout Threshold	V_{IN} ↑; SEL = LOW	5.6	6	6.3	V
		V_{IN} ↑; SEL = HIGH	13.5	14.4	15.2	V
$V_{IN(UVLO)}$	V_{IN} Undervoltage Lockout Threshold	V_{IN} ↓	2.4	--	3.8	V
I_Q	Quiescent Supply Current	ON = HIGH; I_{DS} = 0 A	--	0.5	0.6	mA
I_{SHDN}	OFF Mode Supply Current	ON = LOW; I_{DS} = 0 A	--	1	3	µA
RDS_{ON}	ON Resistance	T_A = 25 °C; I_{DS} = 0.1 A	--	18	20	mΩ
		T_A = 85 °C; I_{DS} = 0.1 A	--	22	24	mΩ
MOSFET IDS	Current from VIN to VOUT	Continuous	--	--	6	A
I_{LIMIT}	Active Current Limit, I_{ACL}	V_{OUT} > 0.5 V; R_{SET} = 30.1 kΩ	2.8	3.2	3.6	A
	Short-circuit Current Limit, I_{SCL}	V_{OUT} < 0.5 V	--	0.5	--	A
T_{ACL}	Active Current Limit Response Time		--	120	--	µs
$R_{DISCHRG}$	Output Discharge Resistance		3.5	4.4	5.3	kΩ
I_{OUT}	MOSFET Current Analog Monitor Output	I_{DS} = 1 A	9.3	10	10.7	µA
		I_{DS} = 3 A	28.5	30	31.5	µA
T_{IOUT}	I_{OUT} Response Time to Change in Main MOSFET Current	C_{IOUT} = 180 pF; Step load 0 to 2.4 A; 0% to 90% I_{OUT}	--	45	--	µs
C_{LOAD}	Output Load Capacitance	C_{LOAD} connected from VOUT to GND	--	22	--	µF

A 12 V, 18 mΩ, 6 A Load Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output

Electrical Characteristics (continued)

4.5 V ≤ V_{IN} ≤ 13.2 V; C_{IN} = 47 µF, T_A = -40 °C to 85 °C, unless otherwise noted. Typical values are at T_A = 25 °C

| Parameter	Description	Conditions	Min.	Typ.	Max.	Unit
T_{ON_Delay}	ON Delay Time	50% ON to 10% V_{OUT} ↑; V_{IN} = 4.5 V; C_{SLEW} = 10 nF; R_{LOAD} = 100 Ω, C_{LOAD} = 10 µF	--	0.3	0.5	ms
		50% ON to 10% V_{OUT} ↑; V_{IN} = 12 V; C_{SLEW} = 10 nF; R_{LOAD} = 100 Ω, C_{LOAD} = 10µF	--	0.7	1.2	ms
T_{Total_ON}	Total Turn ON Time	50% ON to 90% V_{OUT} ↑	Set by External C_{SLEW}[1]			ms
		50% ON to 90% V_{OUT} ↑; V_{IN} = 4.5 V; C_{SLEW} = 10 nF; R_{LOAD} = 100 Ω, C_{LOAD} = 10 µF	--	1.4	2.1	ms
		50% ON to 90% V_{OUT} ↑; V_{IN} = 12 V; C_{SLEW} = 10 nF; R_{LOAD} = 100 Ω, C_{LOAD} = 10 µF	--	5	8	ms
$V_{OUT(SR)}$	V_{OUT} Slew rate	10% V_{OUT} to 90% V_{OUT} ↑	Set by External C_{SLEW}[1]			V/ms
		10% V_{OUT} to 90% V_{OUT} ↑; V_{IN} = 4.5 to 12 V; C_{SLEW} = 10 nF; R_{LOAD} = 100 Ω, C_{LOAD} = 10 µF	2.7	3.2	3.9	V/ms
T_{OFF_Delay}	OFF Delay Time	50% ON to V_{OUT} Fall Start ↓; V_{IN} = 4.5 to 12 V; R_{LOAD} = 100 Ω, No C_{LOAD}	--	15	--	µs
T_{FALL}	V_{OUT} Fall Time	90% V_{OUT} to 10% V_{OUT}; ON = HIGH-to-LOW; V_{IN} = 4.5 to 12 V; R_{LOAD} = 100 Ω, No C_{LOAD}	10.4	12.7	14.3	µs
$\overline{TFAULT}_{LOW}$	$\overline{FAULT}$ Assertion Time	Abnormal Step Load Current event to $\overline{FAULT}$↓; I_{ACL} = 1 A; V_{IN} = 12 V; R_{SET} = 91 kΩ; switch in 10 Ω load	--	80	--	µs
$\overline{TFAULT}_{HIGH}$	$\overline{FAULT}$ De-assertion Time	Delay to $\overline{FAULT}$↑ after fault condition is removed; I_{ACL} = 1 A; V_{IN} = 12 V; R_{SET} = 91 kΩ; switch out 10 Ω load	--	180	--	µs
$\overline{FAULT}_{VOL}$	$\overline{FAULT}$ Output Low Voltage	$I_{\overline{FAULT}}$ = 1 mA	--	0.2	--	V
ON_V_{IH}	ON Pin Input High Voltage		0.9	--	5	V
ON_V_{IL}	ON Pin Input Low Voltage		-0.3	0	0.3	V
SEL_V_{IH}	SEL pin Input High Voltage		1.65	--	4.5	V
SEL_V_{IL}	SEL pin Input Low Voltage		-0.3	--	0.3	V
$I_{ON(Leakage)}$	ON Pin Leakage Current	1 V ≤ ON ≤ 5 V or ON = GND	--	--	1	µA
$THERM_{ON}$	Thermal Protection Shutdown Threshold		--	150	--	°C
$THERM_{OFF}$	Thermal Protection Restart Threshold		--	125	--	°C

Notes:
1. Refer to typical Timing Parameter vs. C_{SLEW} performance charts for additional information when available.

A 12 V, 18 mΩ, 6 A Load Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output

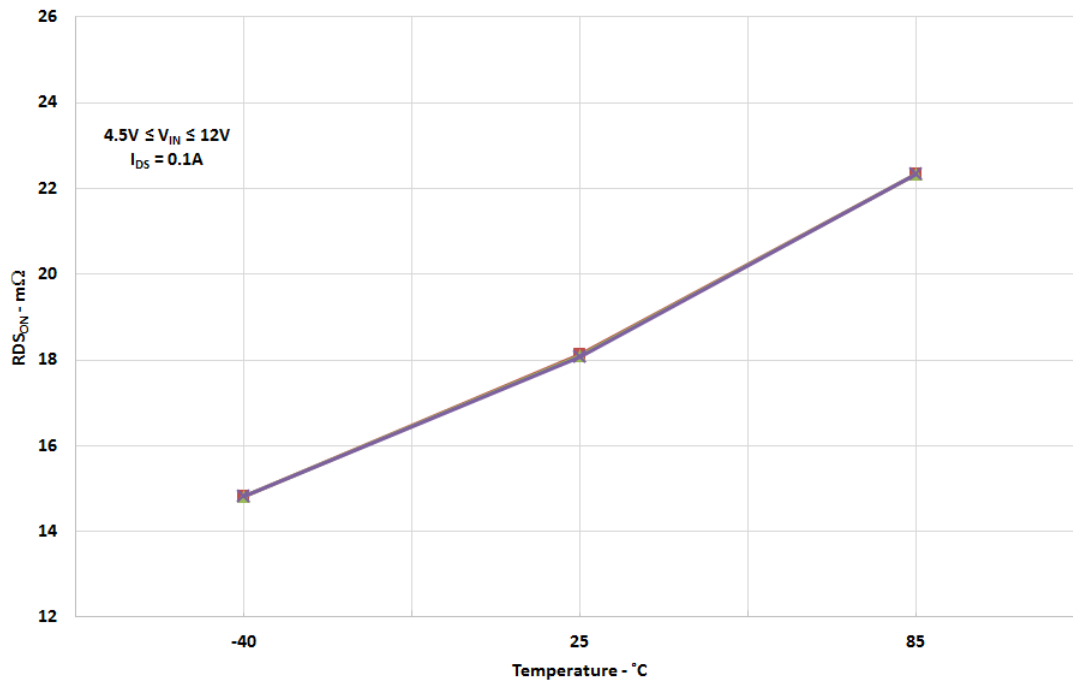**T_{Total_ON}, T_{ON_Delay} and Slew Rate Measurement**
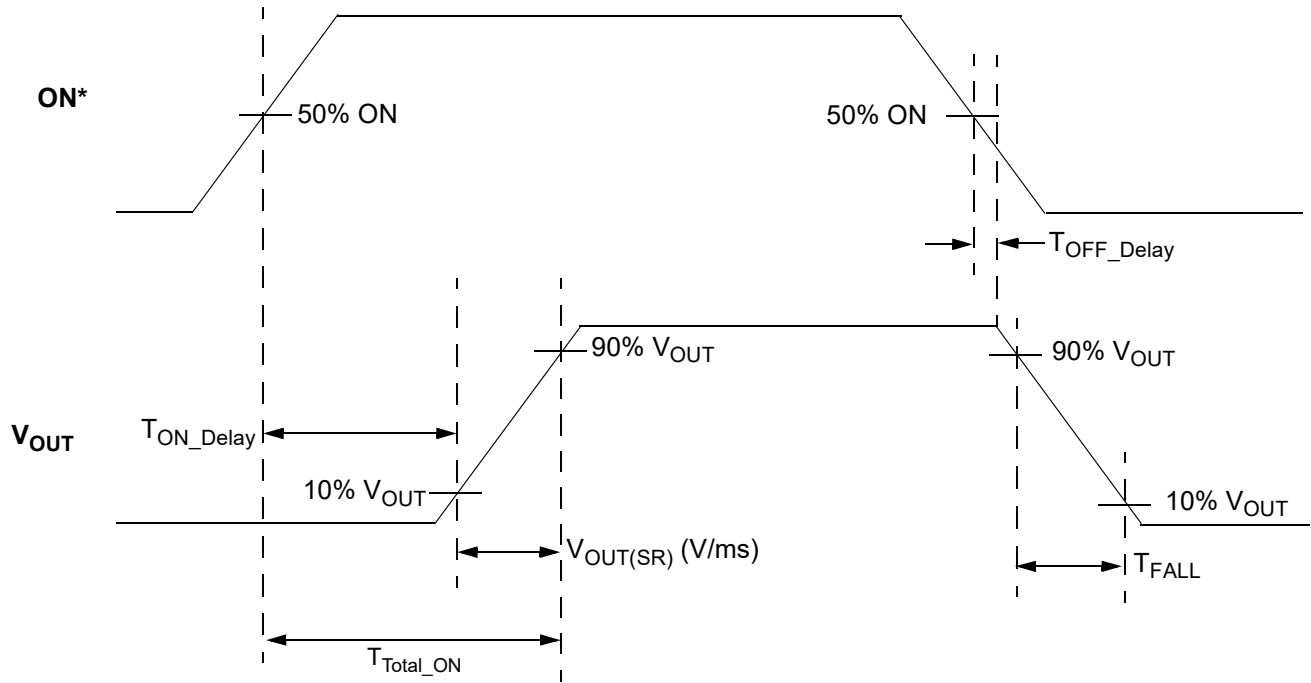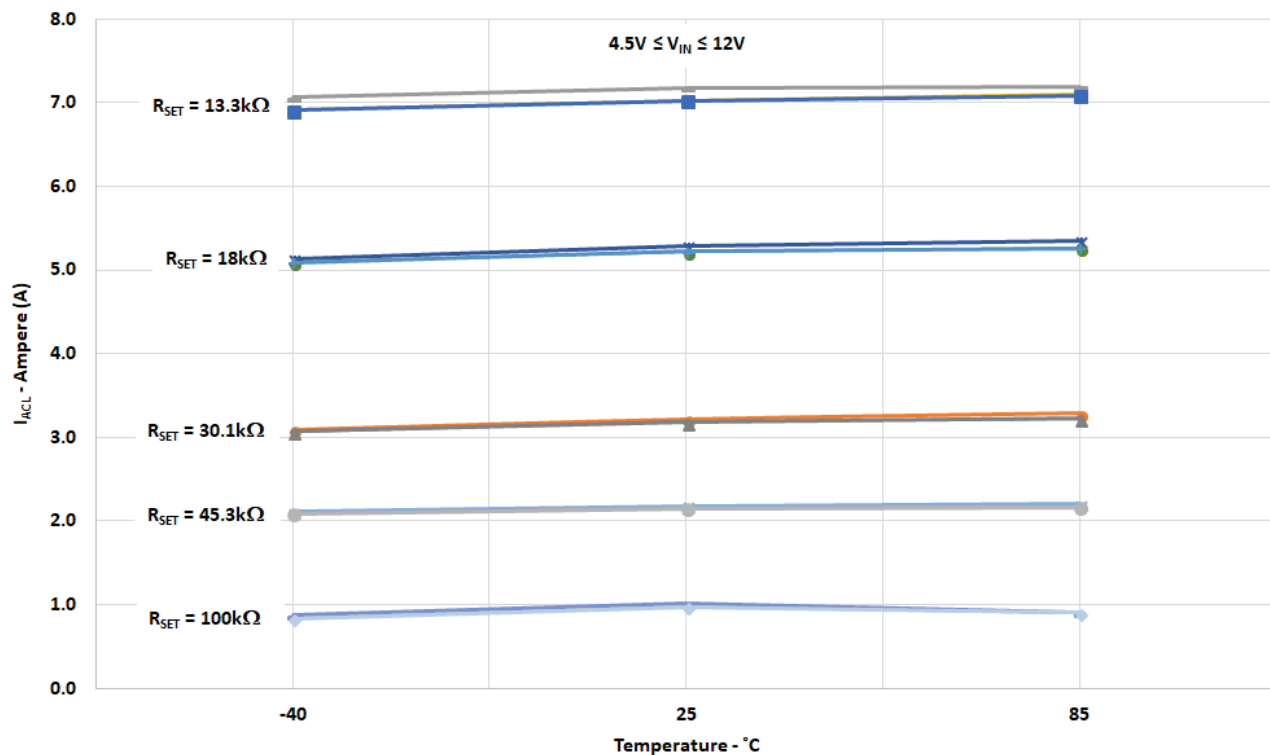

*Rise and Fall Times of the ON Signal are 100 ns

RENESAS

Typical Performance Characteristics
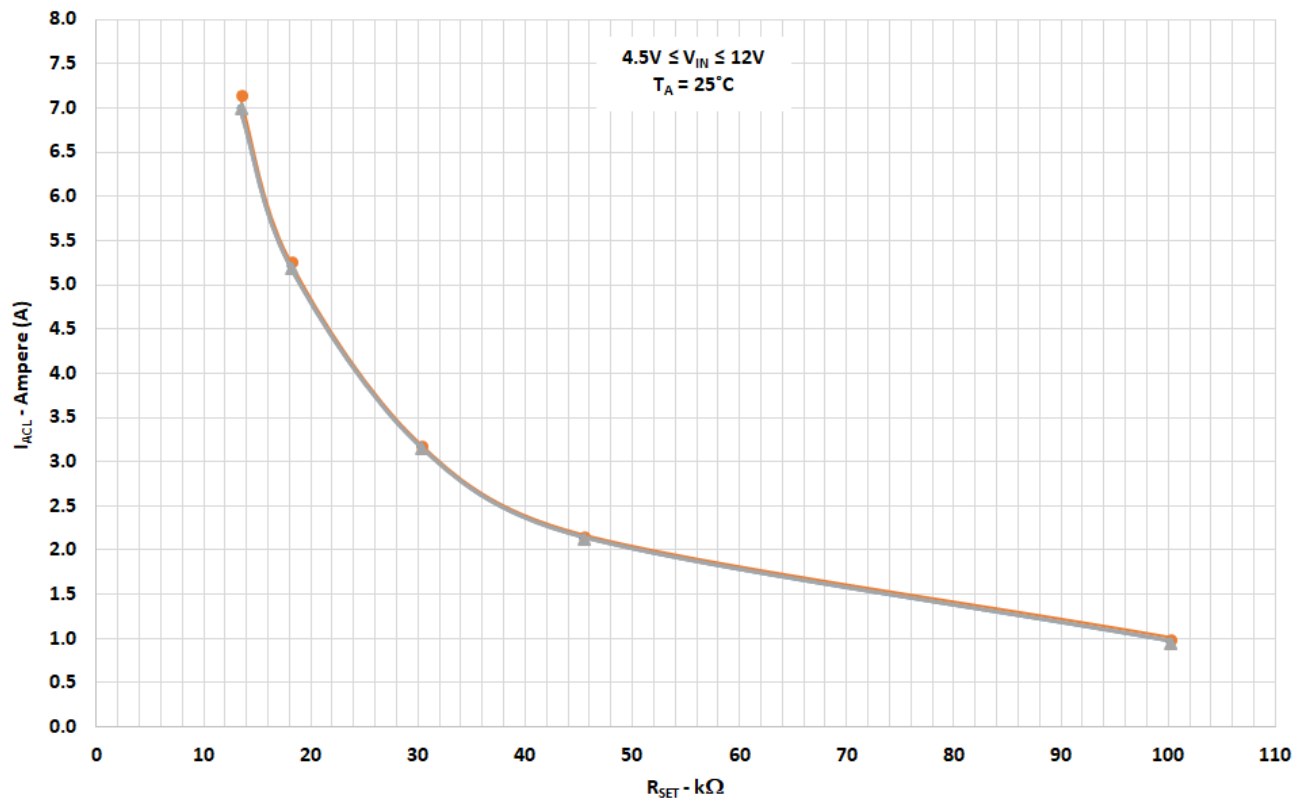
RDS$_{ON}$ vs. Temperature, and V$_{IN}$

I$_{ACL}$ vs. Temperature, R$_{SET}$, and V$_{IN}$

A 12 V, 18 mΩ, 6 A Load Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output

I_{ACL} vs. R_{SET}, and V_{IN}

4.5V ≤ V_{IN} ≤ 12V
T_A = 25°C

I_{OUT} vs. MOSFET IDS and V_{IN}
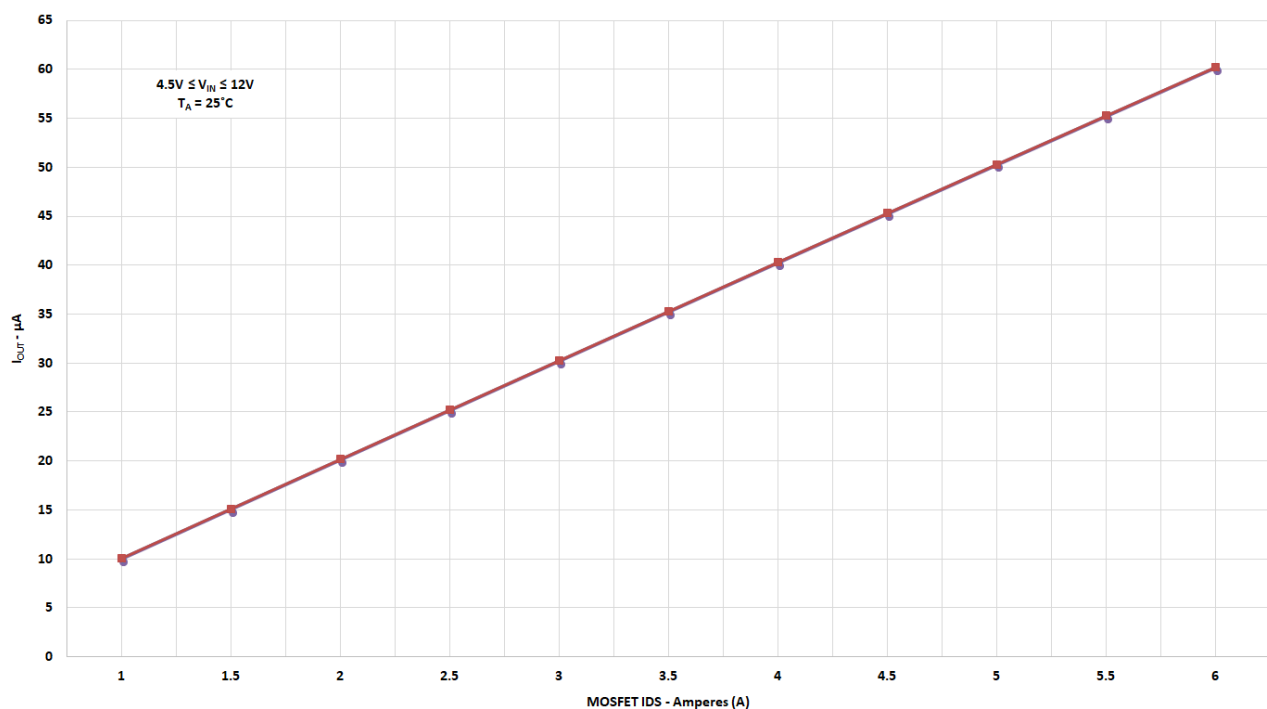
4.5V ≤ V_{IN} ≤ 12V
T_A = 25°C

A 12 V, 18 mΩ, 6 A Load Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output

I_{OUT} vs. Temperature and MOSFET IDS, and V_{IN}
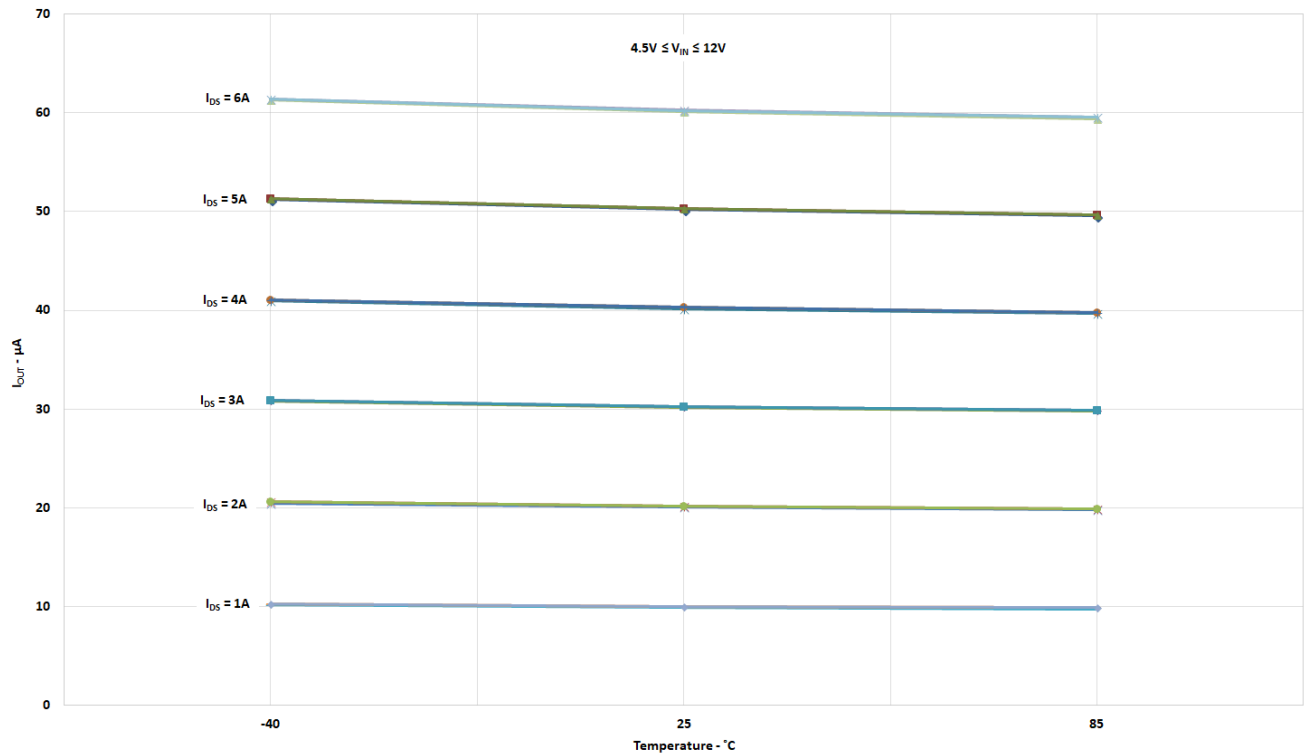
V_{OUT} Slew Rate vs. Temperature, V_{IN}, and C_{SLEW}

T_{Total_ON} vs. C_{SLEW}, V_{IN}, and Temperature
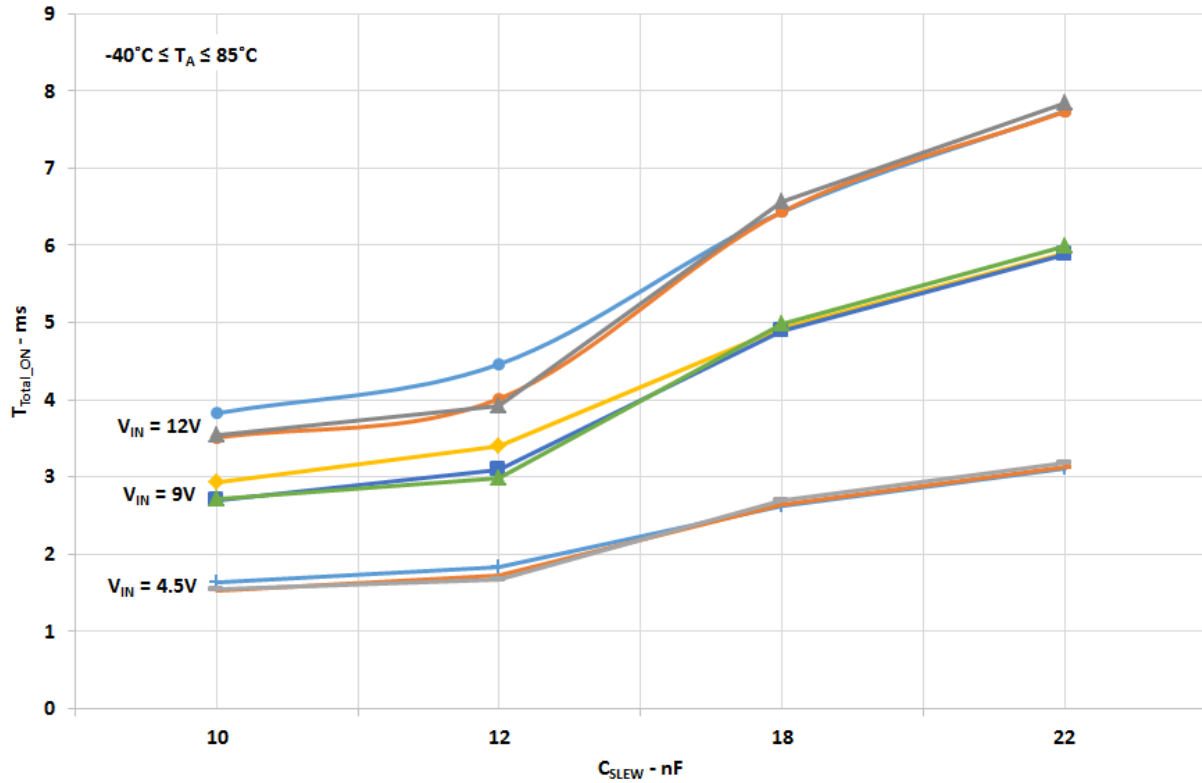
Datasheet

Revision 1.02

1-Feb-2022

CFR0011-120-01

Page 9 of 27

©2022 Renesas Electronics Corporation

Timing Diagram - Basic Operation including Active Current Limit Protection
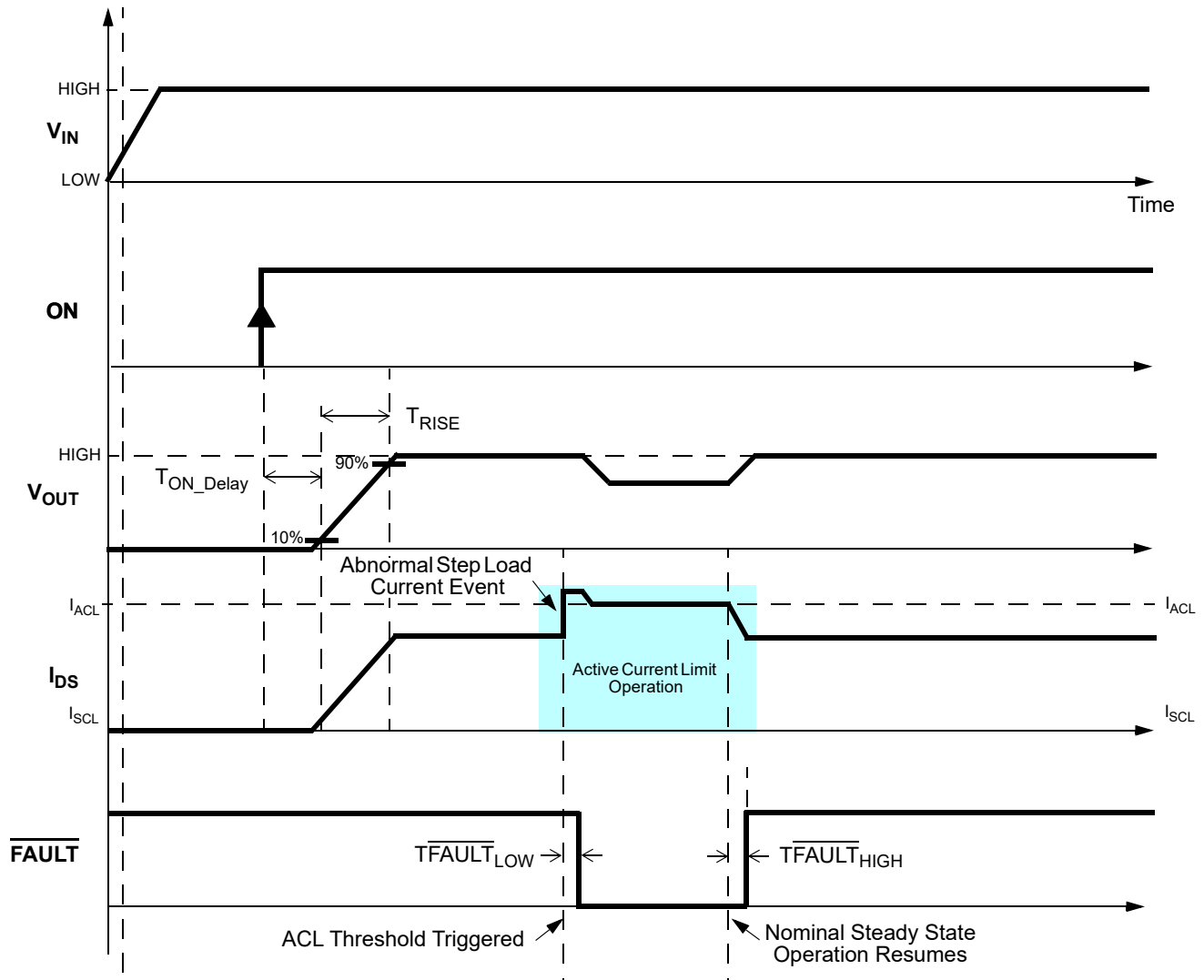
A 12 V, 18 mΩ, 6 A Load Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output

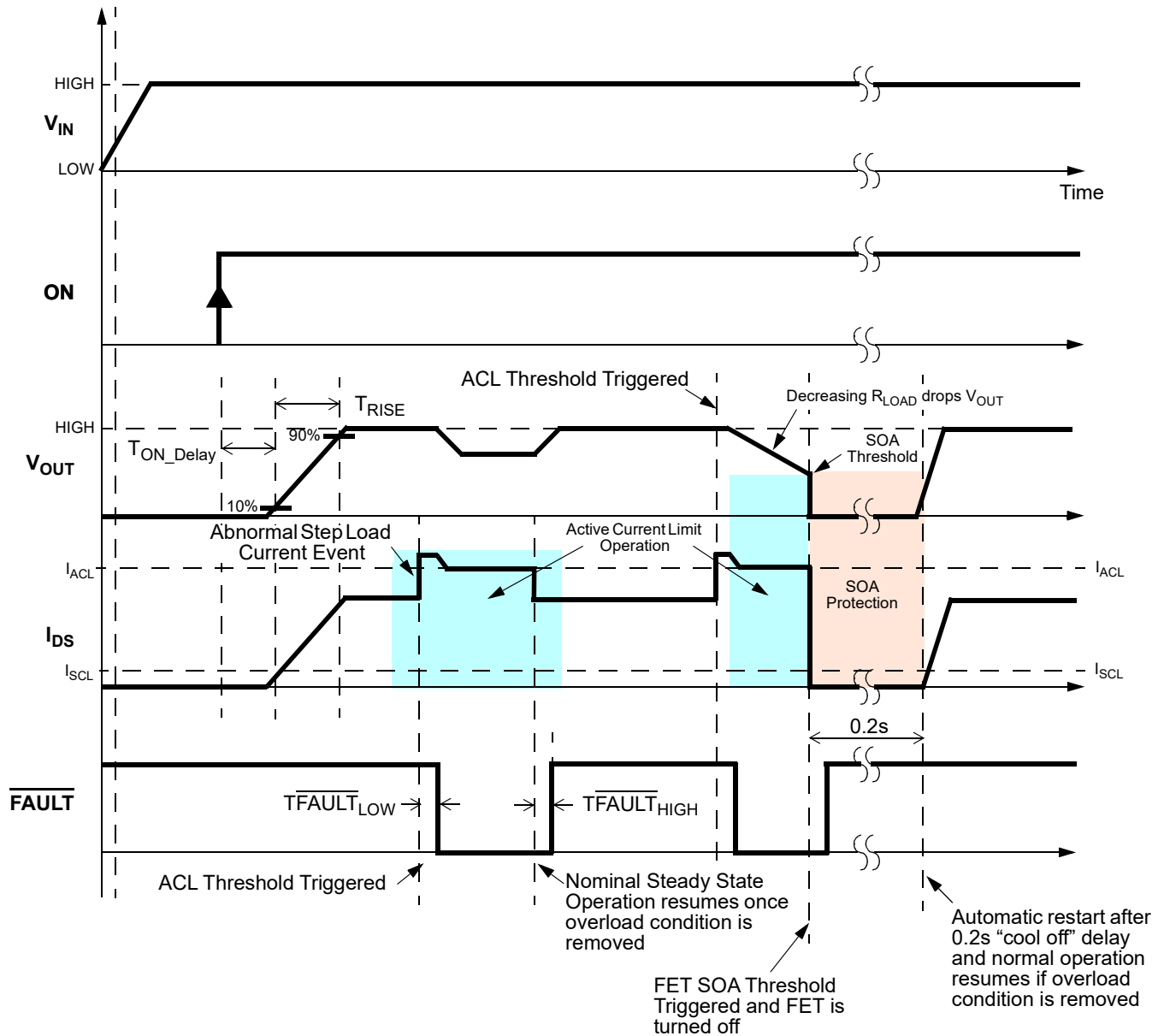## Timing Diagram - Active Current Limit & Thermal Protection Operation
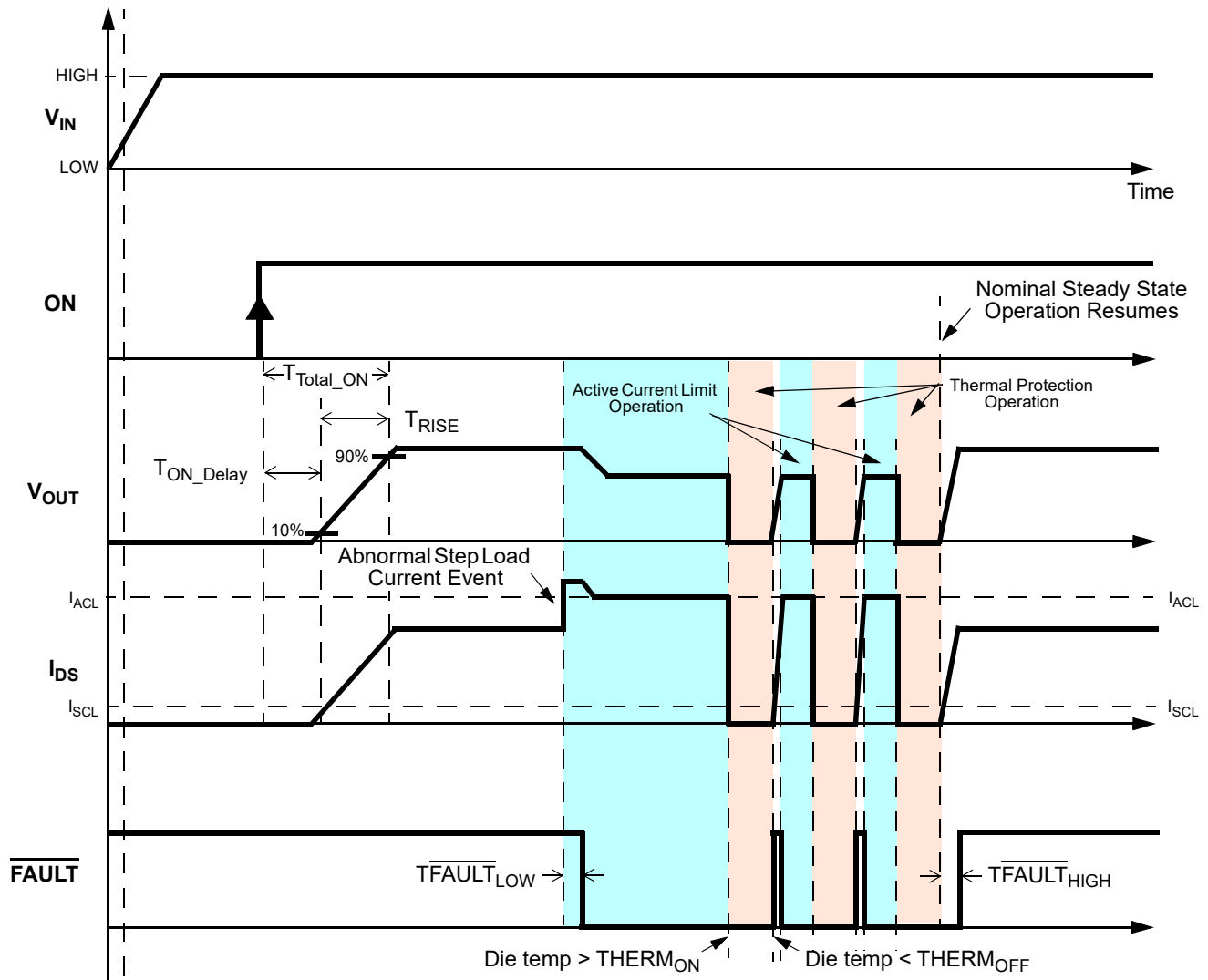
RENESAS

A 12 V, 18 mΩ, 6 A Load Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output

Timing Diagram - Basic Operation including Active Current + Internal FET SOA Protection

A 12 V, 18 mΩ, 6 A Load Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output

SLG59H1126V Application Diagram

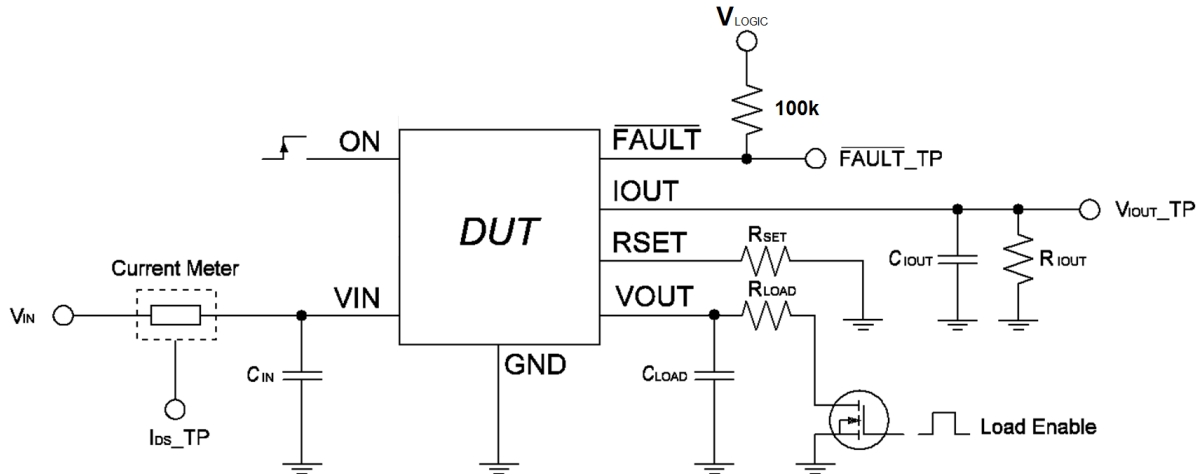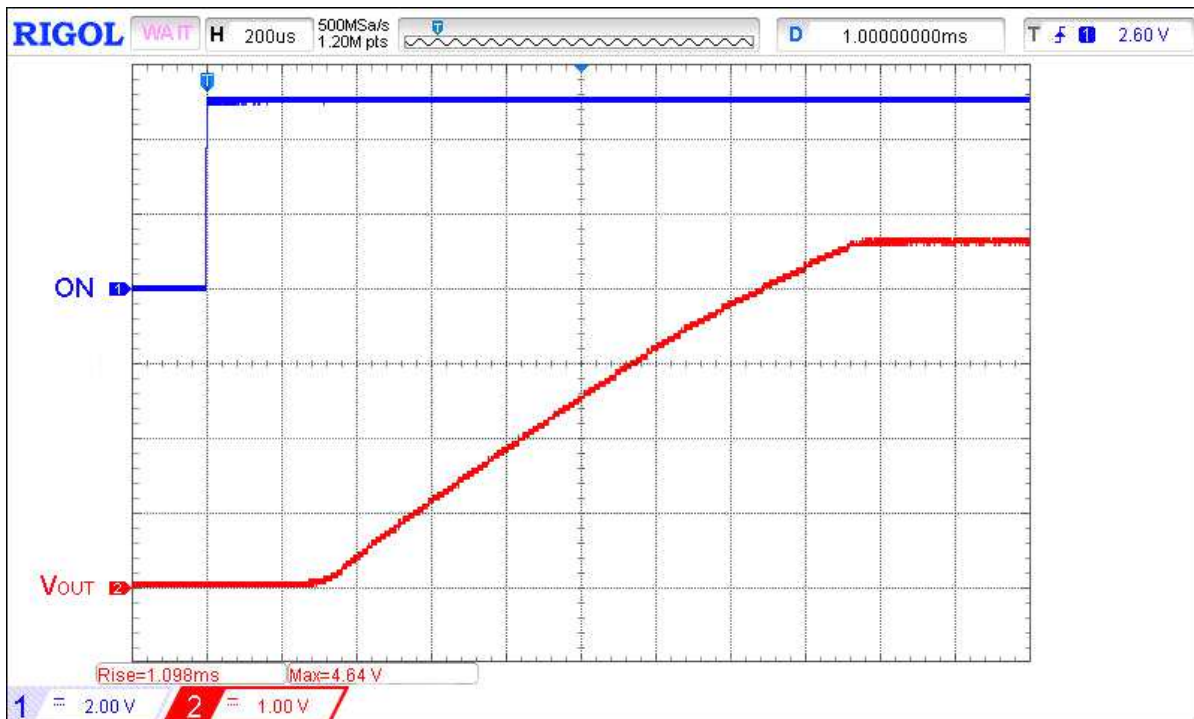**Figure 1. Test setup Application Diagram**

Typical Turn-on Waveforms

Figure 2. Typical Turn ON operation waveform for V_{IN} = 4.5 V, C_{SLEW} = 10 nF, C_{LOAD} = 10 μF, R_{LOAD} = 100 Ω
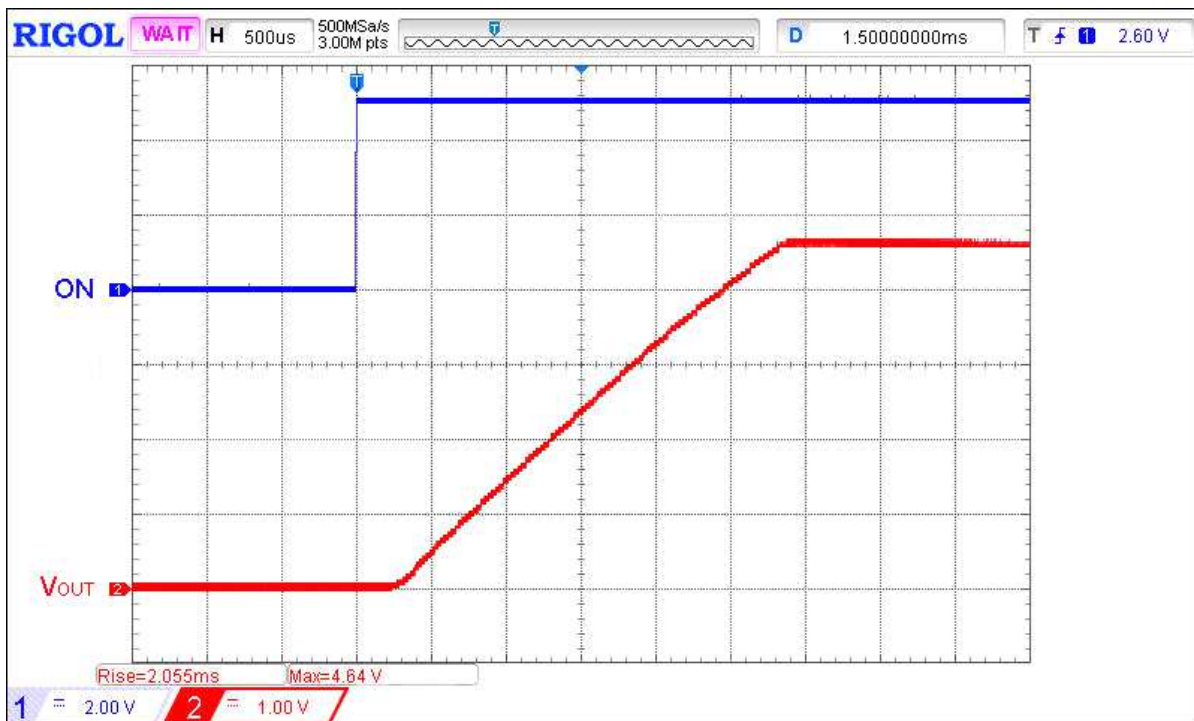
Figure 3. Typical Turn ON operation waveform for V_{IN} = 4.5 V, C_{SLEW} = 18 nF, C_{LOAD} = 10 µF, R_{LOAD} = 100 Ω

Typical Turn-off Waveforms

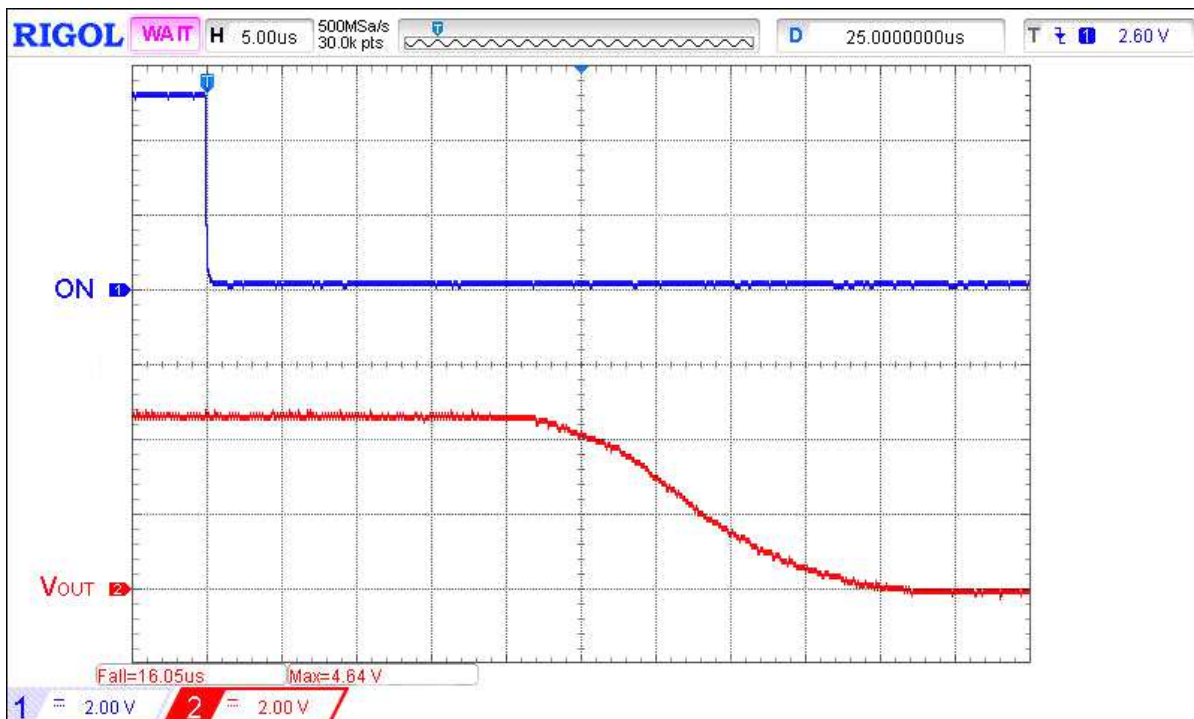**Figure 4. Typical Turn OFF operation waveform for V_{IN} = 4.5 V, C_{SLEW} = 10 nF, no C_{LOAD} , R_{LOAD} = 100 Ω**

A 12 V, 18 mΩ, 6 A Load Switch
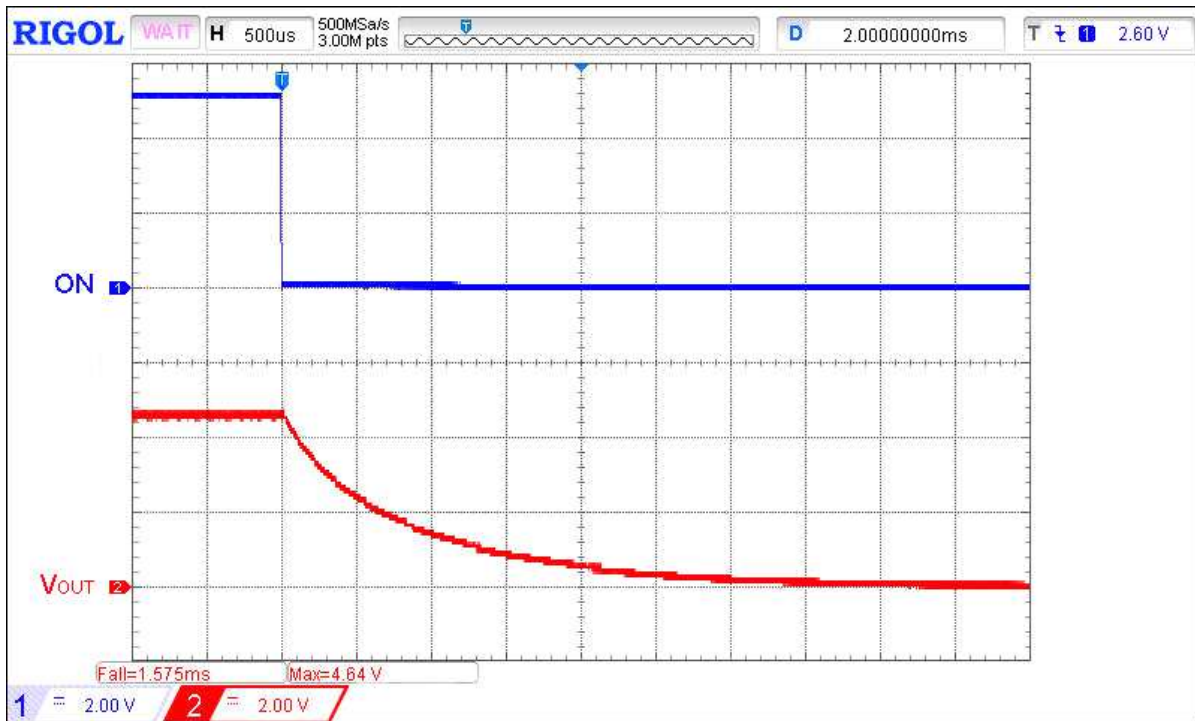### with V_{IN} Lockout Select and MOSFET Current Monitor Output

Figure 5. Typical Turn OFF operation waveform for V_{IN} = 4.5 V, C_{SLEW} = 10 nF, C_{LOAD} = 10 µF, R_{LOAD} = 100 Ω
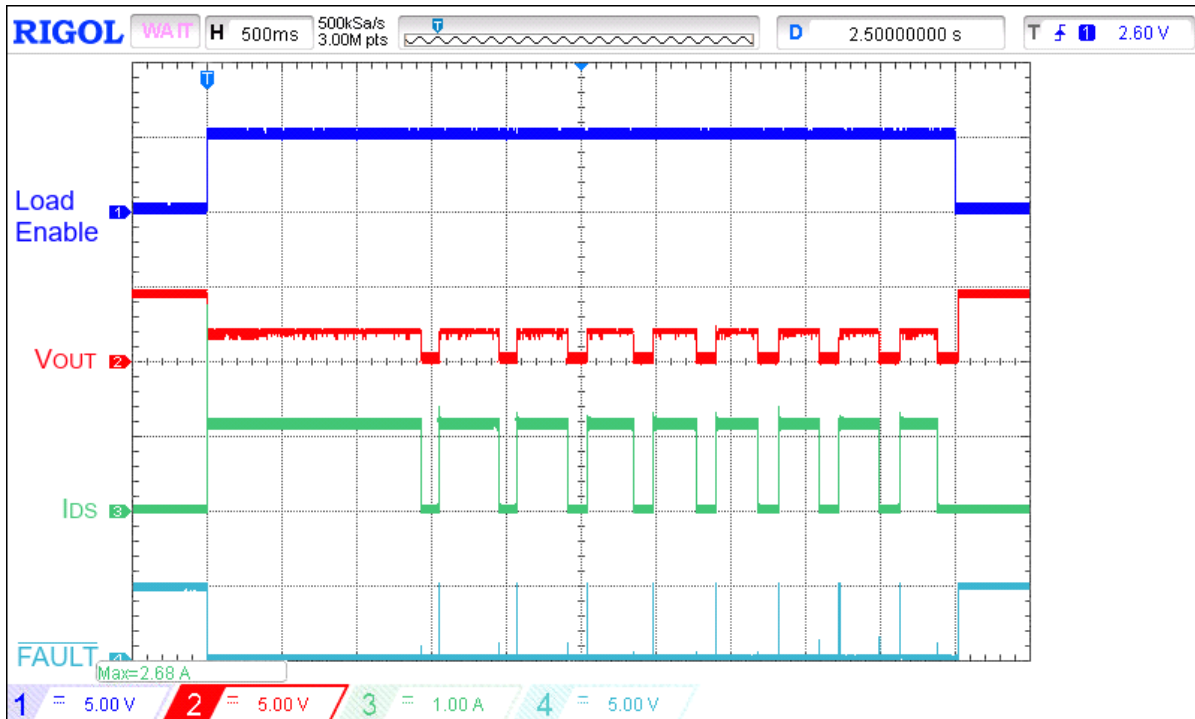
Typical ACL Operation Waveforms

Figure 6. Typical ACL operation waveform for V_{IN} = 4.5 V, C_{LOAD} = 10 µF, I_{ACL} = 1 A, R_{SET} = 91 kΩ

A 12 V, 18 mΩ, 6 A Load Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output
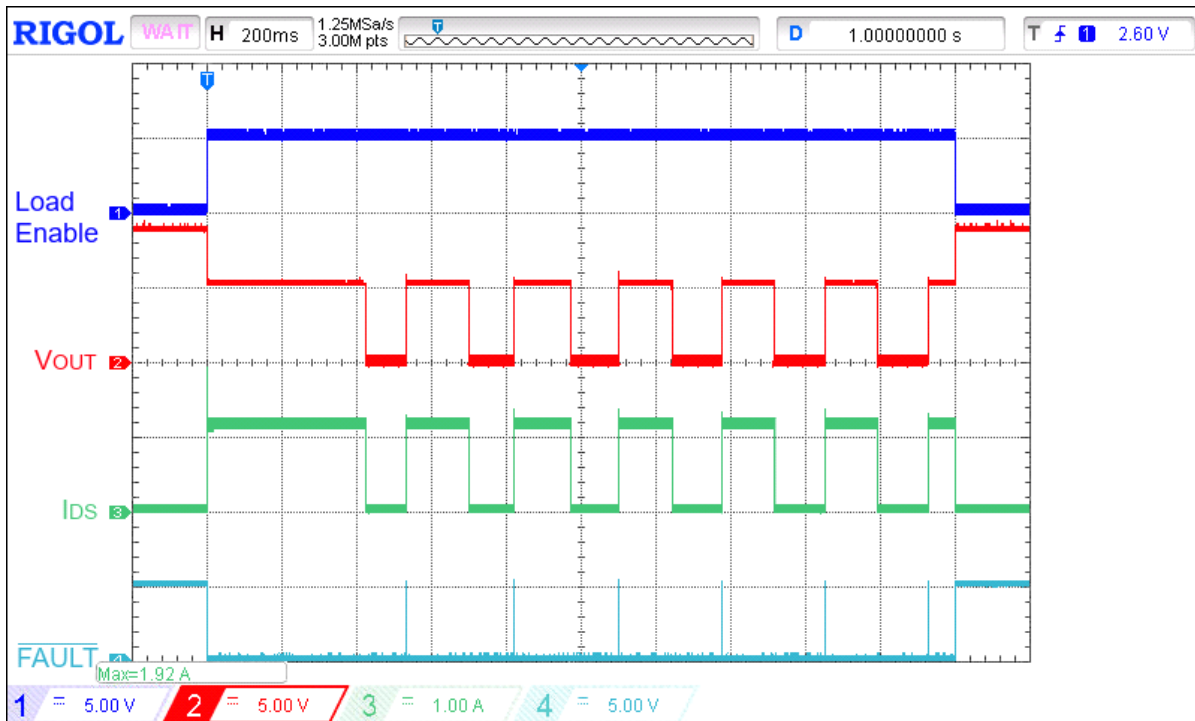
Figure 7. Typical ACL operation waveform for V_{IN} = 9 V, C_{LOAD} = 10 μF, I_{ACL} = 1 A, R_{SET} = 91 kΩ

Typical FAULT Operation Waveforms
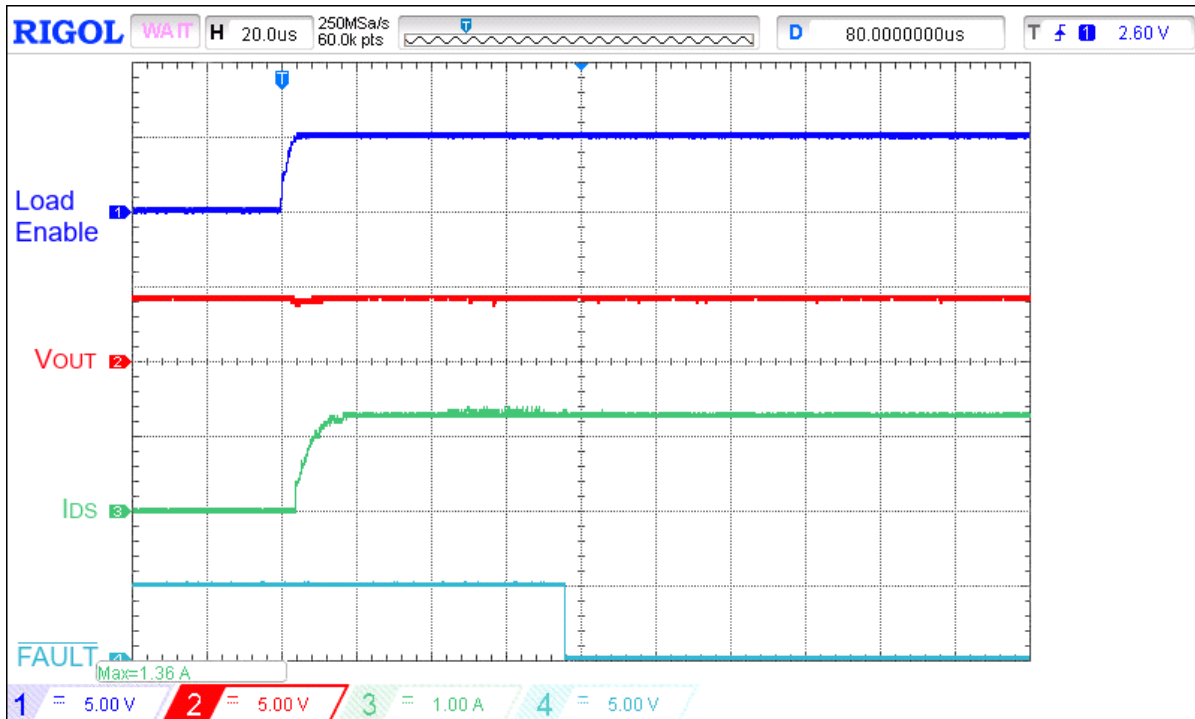
Figure 8. Typical FAULT assertion waveform for V_{IN} = 4.5 V, C_{LOAD} = 10 μF, I_{ACL} = 1 A, R_{SET} = 91 kΩ, switch in 3.3 Ω load

A 12 V, 18 mΩ, 6 A Load Switch
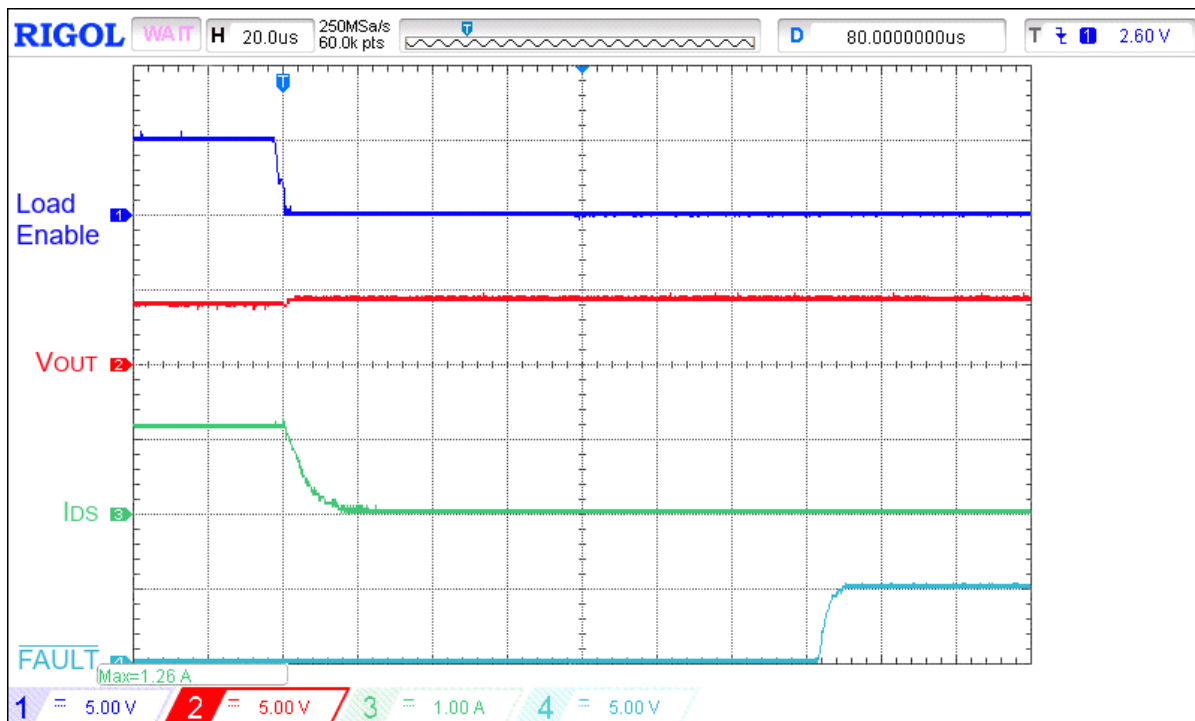with V$_{IN}$ Lockout Select and MOSFET Current Monitor Output

Figure 9. Typical $\overline{\text{FAULT}}$ de-assertion waveform for V$_{IN}$ = 4.5 V, C$_{LOAD}$ = 10 µF, I$_{ACL}$ = 1 A, R$_{SET}$ = 91 kΩ, switch out 3.3 Ω load

A 12 V, 18 mΩ, 6 A Load Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output

Applications Information

High Voltage FET Safe Operating Area Explained

Renesas's High Voltage FET controllers incorporate a number of internal protection features that prevents them from damaging themselves or any other circuit or subcircuit downstream of them. One particular protection feature is their Safe Operation Area (SOA) protection. SOA protection is automatically activated under overpower and, in some cases, under overcurrent conditions. Overpower SOA is activated if package power dissipation exceeds an internal 5 W threshold longer than 2.5 ms. High Voltage FET devices will quickly switch off (open circuit) upon overpower detection and automatically resume (close) nominal operation once overpower condition no longer exists.

One possible way to have an overpower condition trigger SOA protection is when High Voltage FET products are enabled into heavy output resistive loads and/or into large load capacitors. It is under these conditions to follow carefully the "Safe Start-up Loading" guidance in the Applications section of the datasheet. During an overcurrent condition, High Voltage FET devices will try to limit the output current to the level set by the external R_{SET} resistor. Limiting the output current, however, causes an increased voltage drop across the FET's channel because the FET's RDS_{ON} increased as well. Since the FET's RDS_{ON} is larger, package power dissipation also increases. If the resultant increase in package power dissipation is higher/equal than 5 W for longer than 2.5 ms, internal SOA protection will be triggered and the FET will open circuit (switch off). Every time SOA protection is triggered, all High Voltage FET devices will automatically attempt to resume nominal operation after 160 ms.

Safe Start-up Condition

SLG59H1126V has built-in protection to prevent over-heating during start-up into a heavy load. Overloading the VOUT pin with a capacitor and a resistor may result in non-monotonic V_{OUT} ramping. In general, under light loading on VOUT, V_{OUT} ramping can be controlled with C_{SLEW} value. The following equation serves as a guide:

$$C_{SLEW} = \frac{T_{RISE}}{V_{IN}} \times 4.9 \text{ μA} \times \frac{20}{3}$$

where
T_{RISE} = Total rise time from 10% V_{OUT} to 90% V_{OUT}
V_{IN} = Input Voltage
C_{SLEW} = Capacitor value for CAP pin

When capacitor and resistor loading on VOUT during start up, the following tables will ensure V_{OUT} ramping is monotonic without triggering internal protection:

Safe Start-up Loading for V_{IN} = 12 V (Monotonic Ramp)			
Slew Rate (V/ms)	C_{SLEW} (nF)[2]	C_{LOAD} (μF)	R_{LOAD} (Ω)
1	33.3	500	20
2	16.7	250	20
3	11.1	160	20
4	8.3	120	20
5	6.7	100	20

Note 2: Select the closest-value tolerance capacitor.

A 12 V, 18 mΩ, 6 A Load Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output

Setting the SLG59H1126V's Active Current Limit

R_{SET} (kΩ)	Active Current Limit (A) [3]
91	1
45	2
30	3
15	6
13.3	7

Note 3: Active Current Limit accuracy is ±15% over voltage range and over temperature range.

Setting the SLG59H1126V's Input Overvoltage Lockout Threshold

As shown in the table below, SEL selects the V_{IN} overvoltage threshold at which the SLG59H1126V's internal state machine will turn OFF (open circuit) the power MOSFET if V_{IN} exceeds the selected threshold.

SEL	$V_{IN(OVLO)}$ (Typ)
0	6 V
1	14.4 V

With an activated SLG59H1126V (ON=HIGH) and at any time V_{IN} crosses the programmed V_{IN} overvoltage threshold, the state machine opens the load switch and asserts the $\overline{FAULT}$ pin within $TFAULT_{LOW}$.

In applications with a deactivated or inactive SLG59H1126V ($V_{IN} > V_{IN(UVLO)}$ and ON = LOW) and if the applied V_{IN} is higher than the programmed $V_{IN(OVLO)}$ threshold, the SLG59H1126V's state machine will keep the load switch open circuited if the ON pin is toggled LOW-to-HIGH. In these cases, the $\overline{FAULT}$ pin will also be asserted within $TFAULT_{LOW}$ and will remain asserted until V_{IN} resumes nominal, steady-state operation.

In all cases, the SLG59H1126V's V_{IN} undervoltage lockout threshold is fixed at $V_{IN(UVLO)}$.

A 12 V, 18 mΩ, 6 A Load Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output

Power Dissipation

The junction temperature of the SLG59H1126V depends on different factors such as board layout, ambient temperature, and other environmental factors. The primary contributor to the increase in the junction temperature of the SLG59H1126V is the power dissipation of its power MOSFET. Its power dissipation and the junction temperature in nominal operating mode can be calculated using the following equations:

$$PD = RDS_{ON} \times I_{DS}^{2}$$

where:

PD = Power dissipation, in Watts (W)
RDS_{ON} = Power MOSFET ON resistance, in Ohms (Ω)
I_{DS} = Output current, in Amps (A)
and

$$T_{J} = PD \times \theta_{JA} + T_{A}$$

where:

T_{J} = Junction temperature, in Celsius degrees (°C)
θ_{JA} = Package thermal resistance, in Celsius degrees per Watt (°C/W)
T_{A} = Ambient temperature, in Celsius degrees (°C)

In current-limit mode, the SLG59H1126V's power dissipation can be calculated by taking into account the voltage drop across the load switch (V_{IN}-V_{OUT}) and the magnitude of the output current in current-limit mode (I_{ACL}):

$$PD = (V_{IN} - V_{OUT}) \times I_{ACL} \text{ or}$$

$$PD = (V_{IN} - (R_{LOAD} \times I_{ACL})) \times I_{ACL}$$

where:

PD = Power dissipation, in Watts (W)
V_{IN} = Input Voltage, in Volts (V)
R_{LOAD} = Load Resistance, in Ohms (Ω)
I_{ACL} = Output limited current, in Amps (A)
V_{OUT} = $R_{LOAD} \times I_{ACL}$

A 12 V, 18 mΩ, 6 A Load Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output

Layout Guidelines:

1. Since the VIN and VOUT pins dissipate most of the heat generated during high-load current operation, it is highly recommended to make power traces as short, direct, and wide as possible. A good practice is to make power traces with <u>absolute minimum widths</u> of 15 mils (0.381 mm) per Ampere. A representative layout, shown in Figure 10, illustrates proper techniques for heat to transfer as efficiently as possible out of the device;

2. To minimize the effects of parasitic trace inductance on normal operation, it is recommended to connect input C_{IN} and output C_{LOAD} low-ESR capacitors as close as possible to the SLG59H1126V's VIN and VOUT pins;

3. The GND pin should be connected to system analog or power ground plane.

4. 2 oz. copper is recommended for high current operation.

SLG59H1126V Evaluation Board:

A High Voltage FET Evaluation Board for SLG59H1126V is designed according to the statements above and is illustrated on Figure 10. Please note that evaluation board has D_Sense and S_Sense pads. They cannot carry high currents and dedicated only for RDS_{ON} evaluation.
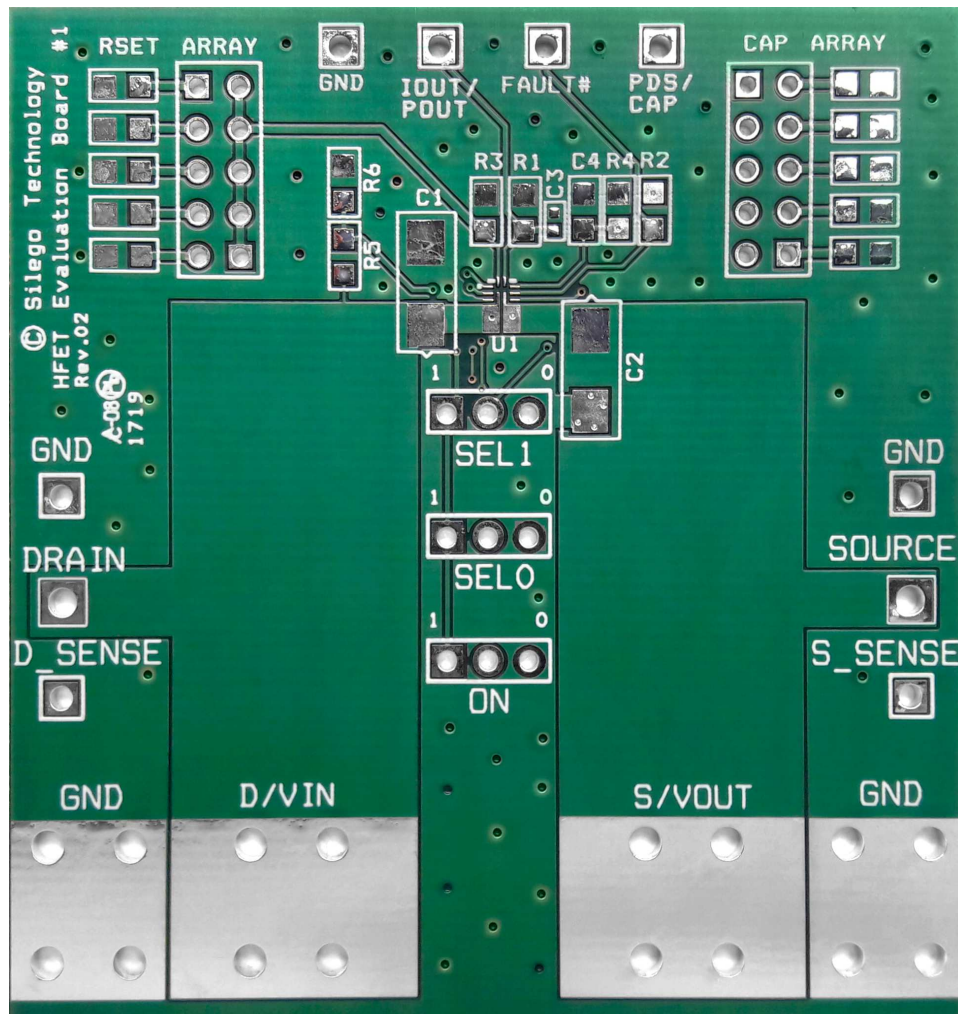

Figure 10. SLG59H1126V Evaluation Board

A 12 V, 18 mΩ, 6 A Load Switch
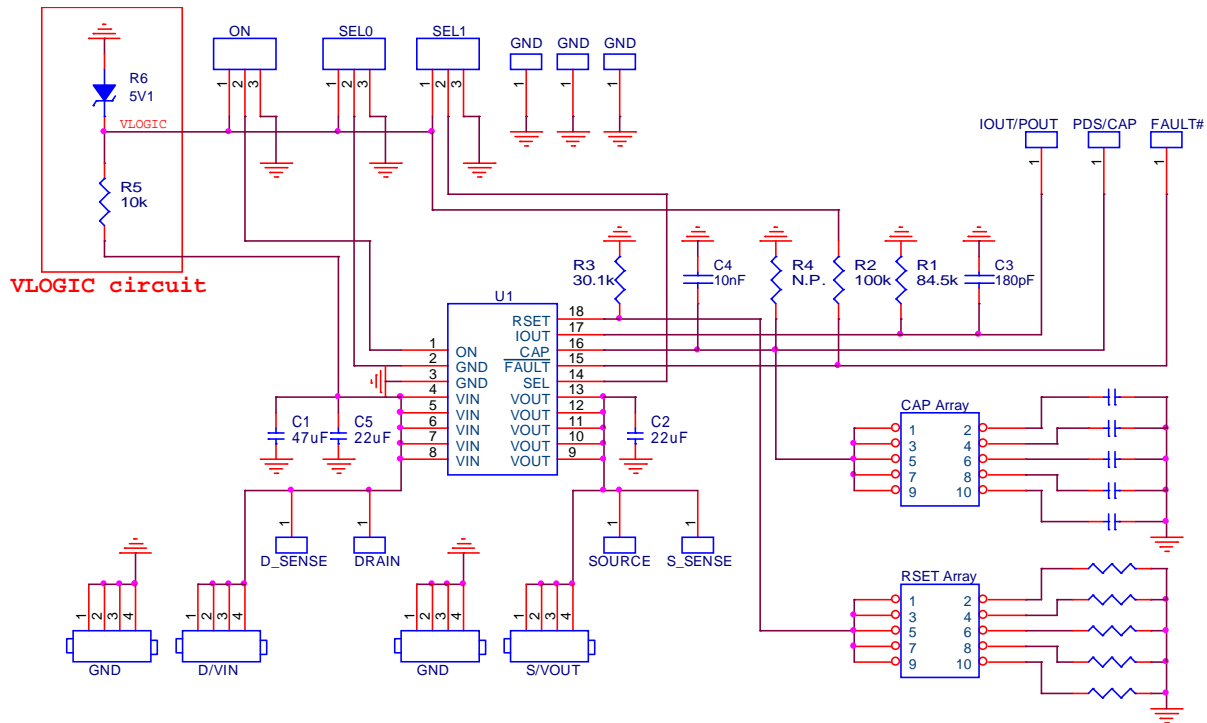## with V_{IN} Lockout Select and MOSFET Current Monitor Output

Figure 11. SLG59H1126V Evaluation Board Connection Circuit

Basic Test Setup and Connections
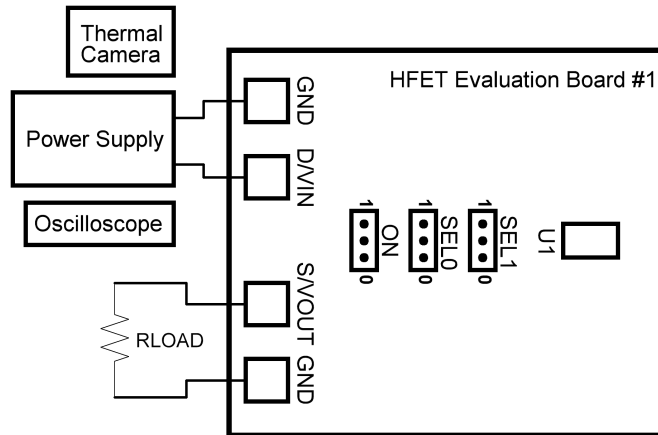

**Figure 12. SLG59H1126V Evaluation Board Connection Circuit**

EVB Configuration

1. Set SEL0 to GND;

2. Based on V_{IN} voltage, set SEL1 to GND or 5 V to configure OVLO;

3. Connect oscilloscope probes to D/VIN, S/VOUT, ON, etc.;

4. Turn on Power Supply and set desired V_{IN} from 4.5 V…12 V range;

5. Toggle the ON signal High or Low to observe SLG59H1126V operation;

RENESAS

A 12 V, 18 mΩ, 6 A Load Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output

Package Top Marking System Definition

1126V — Part Code

WWNNN — Date Code + LOT Code

ARR — Assembly + Rev. Code

Pin 1 Identifier
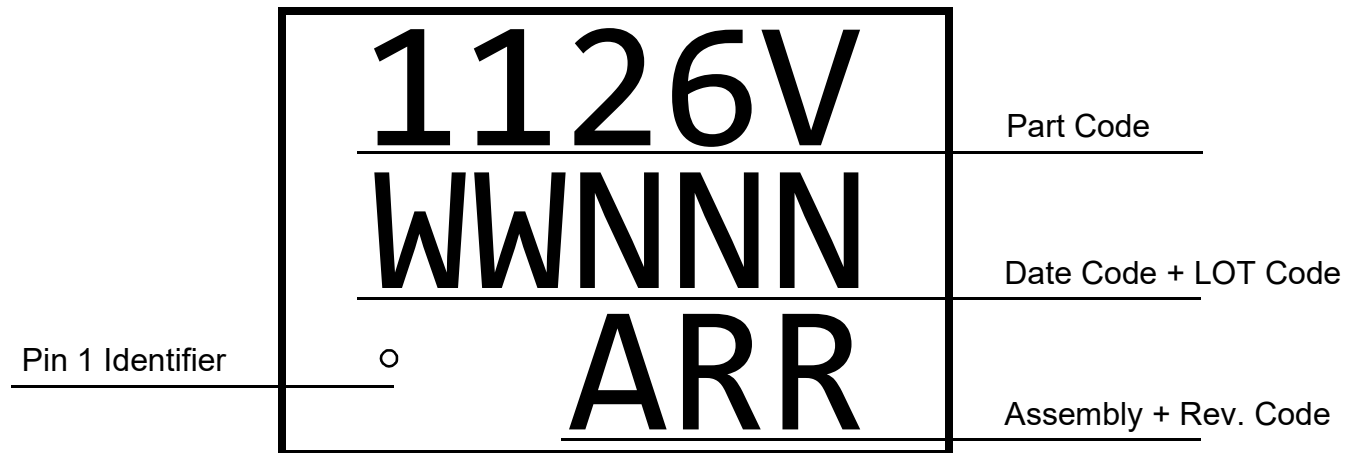
1126V - Part ID Field
WW - Date Code Field[1]
NNN - Lot Traceability Code Field[1]
A - Assembly Site Code Field [2]
RR - Part Revision Code Field[2]

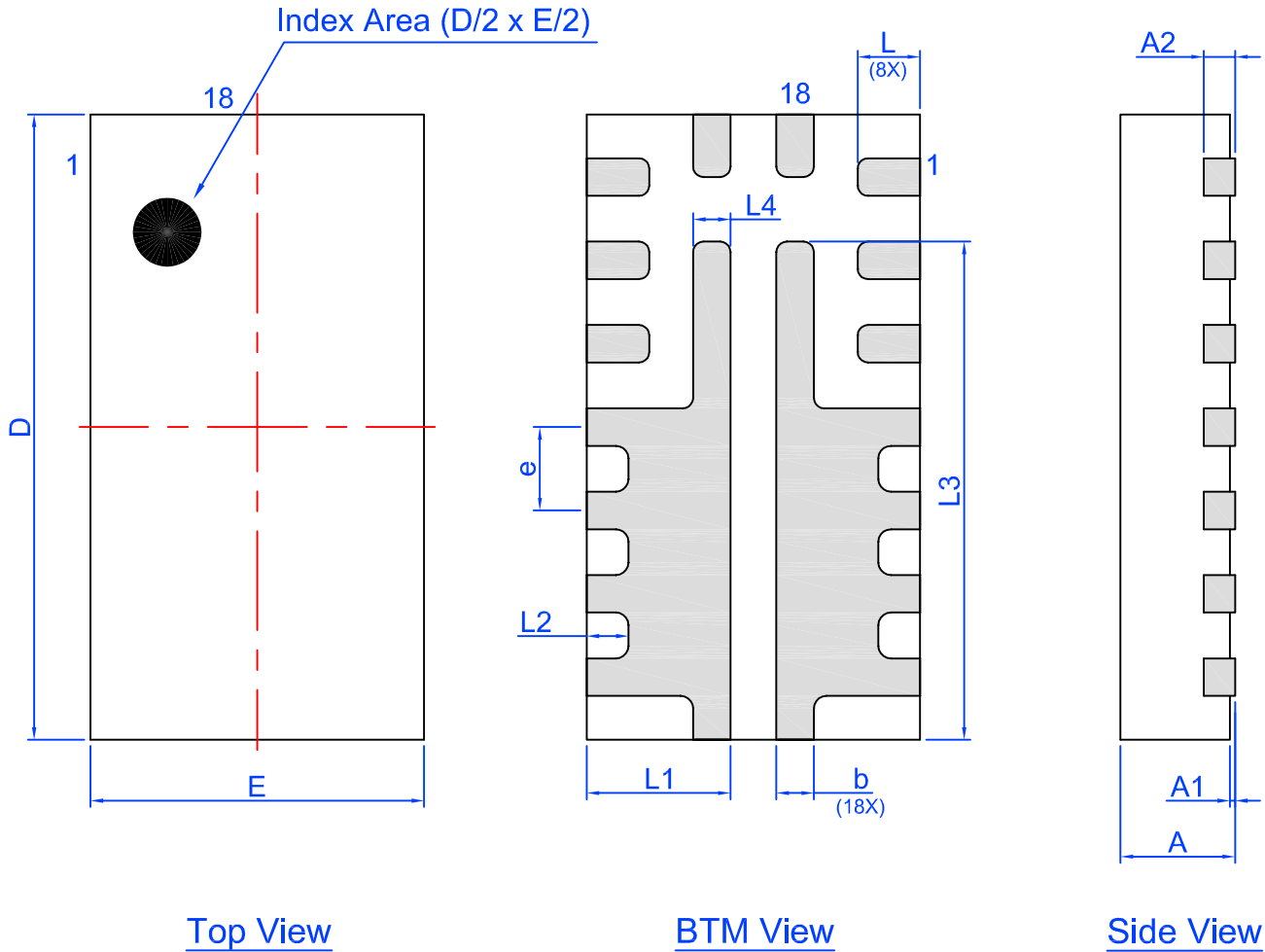Note 1: Each character in code field can be alphanumeric A-Z and 0-9
Note 2: Character in code field can be alphabetic A-Z

A 12 V, 18 mΩ, 6 A Load Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output

Package Drawing and Dimensions

18 Lead TQFN Package 1.6 x 3 mm (Fused Lead)
JEDEC MO-220, Variation WCEE

Index Area (D/2 x E/2)

Top View

BTM View

Side View

Unit: mm

Symbol	Min	Nom.	Max	Symbol	Min	Nom.	Max
A	0.50	0.55	0.60	D	2.95	3.00	3.05
A1	0.005	-	0.05	E	1.55	1.60	1.65
A2	0.10	0.15	0.20	L	0.25	0.30	0.35
b	0.13	0.18	0.23	L1	0.64	0.69	0.74
e	0.40 BSC			L2	0.15	0.20	0.25
L3	2.34	2.39	2.44	L4	0.13	0.18	0.23

A 12 V, 18 mΩ, 6 A Load Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output

SLG59H1126V 18-pin STQFN PCB Landing Pattern

Exposed Pad
(PKG face down)

Recommended Land Pattern
(PKG face down)
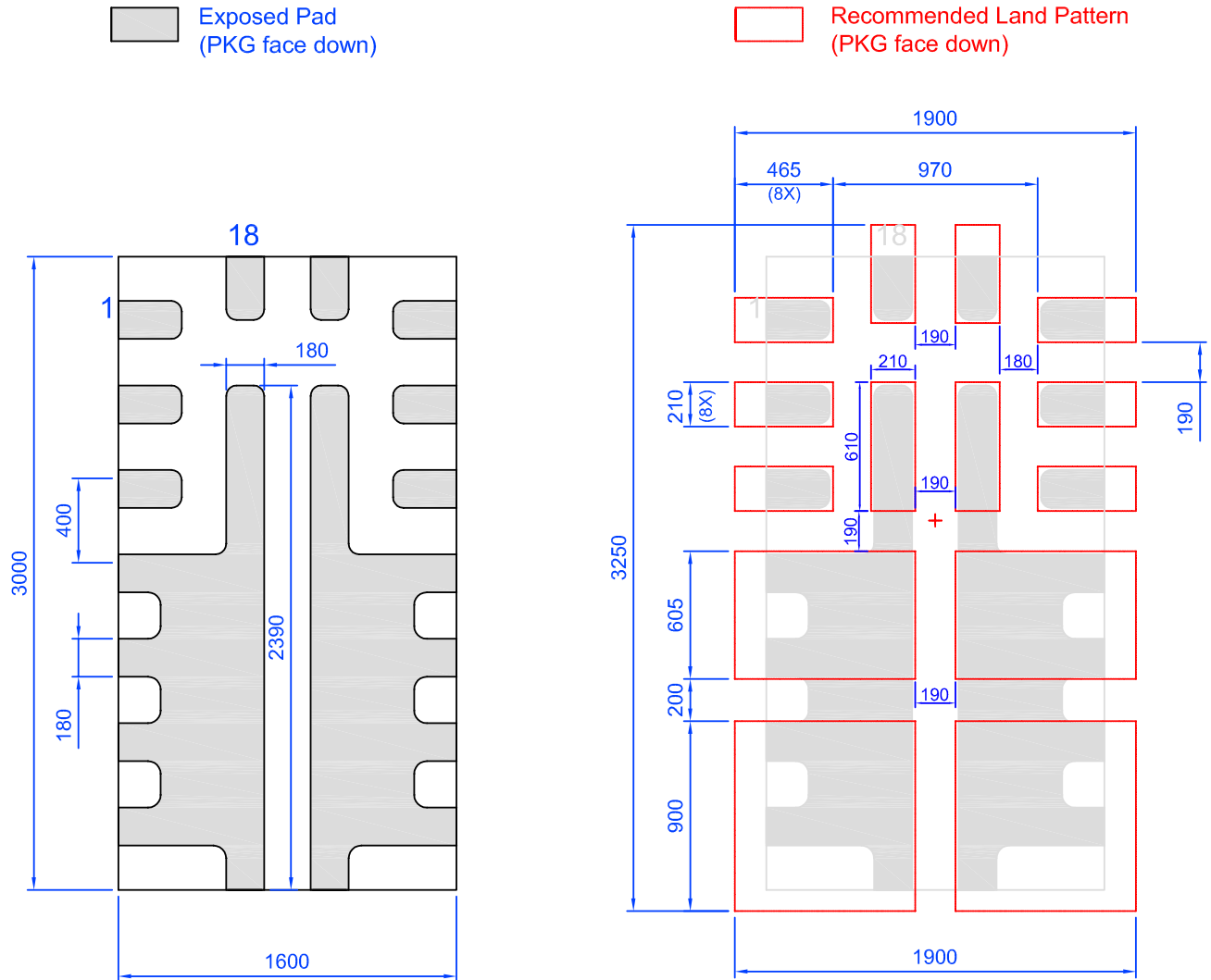
Note: All dimensions shown in micrometers (µm)

A 12 V, 18 mΩ, 6 A Load Switch
with V_{IN} Lockout Select and MOSFET Current Monitor Output

Tape and Reel Specifications

Package Type	# of Pins	Nominal Package Size [mm]	Max Units		Reel & Hub Size [mm]	Leader (min)		Trailer (min)		Tape Width [mm]	Part Pitch [mm]
			per Reel	per Box		Pockets	Length [mm]	Pockets	Length [mm]		
STQFN 18L 1.6x3mm 0.4P FC Green	18	1.6 x 3 x 0.55	3,000	3,000	178 / 60	100	400	100	400	8	4

Carrier Tape Drawing and Dimensions

Package Type	Pocket BTM Length	Pocket BTM Width	Pocket Depth	Index Hole Pitch	Pocket Pitch	Index Hole Diameter	Index Hole to Tape Edge	Index Hole to Pocket Center	Tape Width
	A0	B0	K0	P0	P1	D0	E	F	W
STQFN 18L 1.6x3mm 0.4P FC Green	1.78	3.18	0.76	4	4	1.5	1.75	3.5	8

Refer to EIA-481 specification
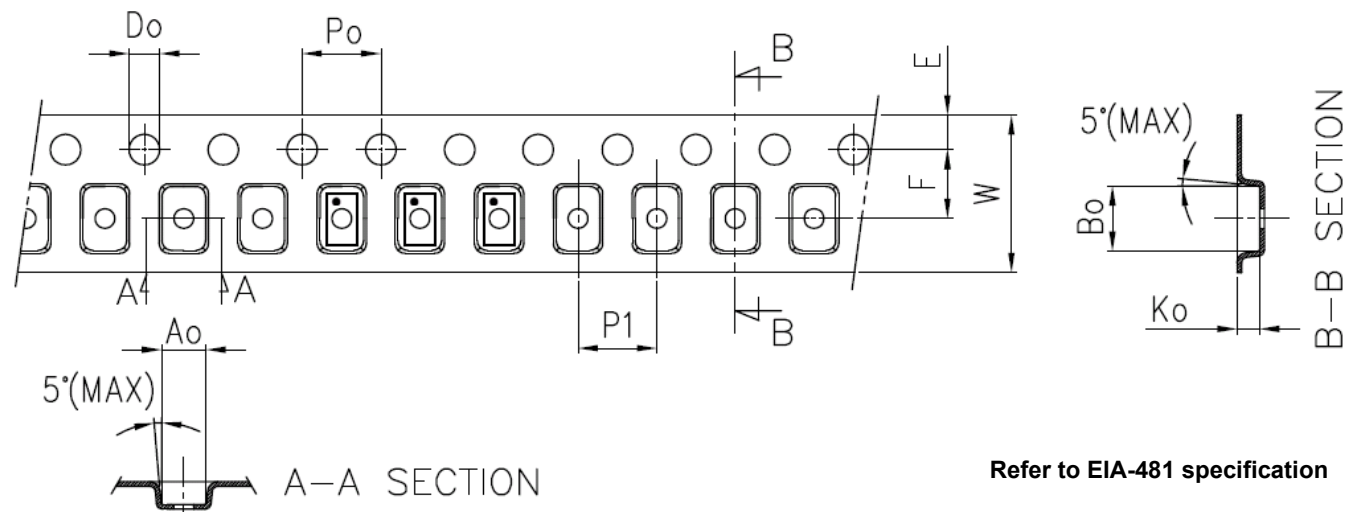
Recommended Reflow Soldering Profile

Please see IPC/JEDEC J-STD-020: latest revision for reflow profile based on package volume of 2.64 mm^3 (nominal). More information can be found at www.jedec.org.

Revision History

Date	Version	Change
2/1/2022	1.02	Updated Company name and logo Added SOA Protection Threshold to Features Fixed typos
6/13/2019	1.01	Fixed typos
12/19/2018	1.00	Production Release

IMPORTANT NOTICE AND DISCLAIMER

RENESAS ELECTRONICS CORPORATION AND ITS SUBSIDIARIES ("RENESAS") PROVIDES TECHNICAL SPECIFICATIONS AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS OR IMPLIED, INCLUDING, WITHOUT LIMITATION, ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE, OR NON-INFRINGEMENT OF THIRD-PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for developers who are designing with Renesas products. You are solely responsible for (1) selecting the appropriate products for your application, (2) designing, validating, and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. Renesas grants you permission to use these resources only to develop an application that uses Renesas products. Other reproduction or use of these resources is strictly prohibited. No license is granted to any other Renesas intellectual property or to any third-party intellectual property. Renesas disclaims responsibility for, and you will fully indemnify Renesas and its representatives against, any claims, damages, costs, losses, or liabilities arising from your use of these resources. Renesas' products are provided only subject to Renesas' Terms and Conditions of Sale or other applicable terms agreed to in writing. No use of any Renesas resources expands or otherwise alters any applicable warranties or warranty disclaimers for these products.

(Disclaimer Rev.1.01 Jan 2024)

Corporate Headquarters

TOYOSU FORESIA, 3-2-24 Toyosu,
Koto-ku, Tokyo 135-0061, Japan
www.renesas.com

Trademarks

Renesas and the Renesas logo are trademarks of Renesas Electronics Corporation. All trademarks and registered trademarks are the property of their respective owners.

Contact Information

For further information on a product, technology, the most up-to-date version of a document, or your nearest sales office, please visit www.renesas.com/contact-us/.

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

[Renesas Electronics](#):

[SLG59H1126V-EVB](#)